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Deep Learning for Data Mining: Theory, Methods, and Applications

Guest Editors:

Message from the Guest Editors

Dr. Lei Guo

Dear Colleagues,

Prof. Dr. Xiushan Nie

Prof. Dr. Vanwei Yu

Dr. Yonghong Yu

Deadline for manuscript submissions:

16 June 2024

Deep learning has succeeded significantly in many application areas, such as object recognition, natural language processing, and information retrieval. Due to the limitations of shallow methods in mining knowledge from data, deep learning technologies are also frequently adopted for data mining tasks, such as classification, prediction, time-series analysis, association, and clustering, which significantly improves the development of the data mining area.

This Special Issue aims to provide an academic platform to publish high-quality research papers on deep learning methods and their applications to data mining, including (but not limited to) extended versions of the outstanding SDAI2023 (https://www.sdaai.org.cn/sdai2023) papers.

Potential topics of interest for this Special Issue include:

- Deep learning theory;
- Deep learning algorithms;
- Graph neural networks;
- Deep reinforcement learning;
- Classification methods;
- Association rule mining;
- User behavior modeling;
- Click-through rate prediction;
- Behavior pattern mining;
- Recommendation methods;
- Clustering algorithms;
- Time-series a Systoe Classue



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Editor-in-Chief

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Message from the Editor-in-Chief

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